## NSN 5962-01-424-3083

Memory Microcircuit - Page 1 of 1



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| End Application:                         |
|--|
| Was/wes test                             |
| Inclosure Configuration:                 |
| Dual-in-line                             |
| Time Rating Per Chacteristic:            |
| 25.00 nanoseconds input to output access |
| Memory Device Type:                      |
| Pal                                      |
| Special Features:                        |
| Programmed pal22v10                      |
| Terminal Type And Quantity:              |
| 24 printed circuit                       |
| Shelf Life:                              |
| N/a                                      |
| Unit Of Measure:                         |
|  |
| Demilitarization:                        |
| Yes - demil/mli                          |
| Fiig:                                    |
| A458a0                                   |
|  |
|  |